

Notice of References Cited

Application/Control No.

10/822,095

Applicant(s)/Patent Under
Reexamination
SHINODA ET AL.

Examiner

VENKATESH HALIYUR

Art Unit

2476

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,767,815	07-2004	Williams, Vernon M.	438/597
*	B	US-6,888,502	05-2005	Beigel et al.	343/700MS
*	C	US-6,761,829	07-2004	Harris et al.	216/2
*	D	US-5,764,491	06-1998	Tran, Thanh T.	361/794
*	E	US-4,774,632	09-1988	Neugebauer, Constantine A.	361/715
*	F	US-5,852,337	12-1998	Takeuchi et al.	310/328
*	G	US-5,488,257	01-1996	Bhattacharyya et al.	257/774
*	H	US-6,310,606	10-2001	Armstrong, Brad A.	345/161
*	I	US-3,954,101	05-1976	Wachspress, How F.	607/115
*	J	US-2003/0001734	01-2003	Schofield et al.	340/442
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.